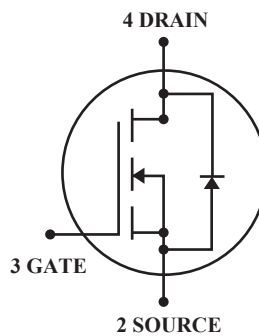
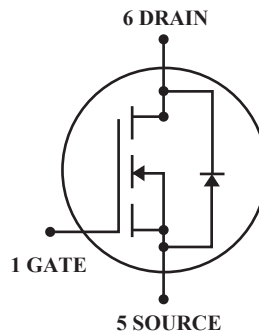


Dual N-Channel Enhancement Mode MOSFET

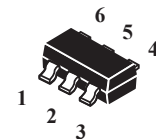
(Pb) Lead(Pb)-Free

Features:

- * Low Gate charge
- * Surface Mount Package



DRAIN CURRENT
520mAMPERES
DRAIN SOURCE VOLTAGE
50 VOLTAGE



SOT-26

Maximum Ratings (T_A=25°C Unless Otherwise Specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	50	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current ³ , V _{GS} @10V	I _D @T _A =25°C	520	mA
Continuous Drain Current ³ , V _{GS} @10V	I _D @T _A =70°C	410	mA
Pulsed Drain Current ¹	I _{DM}	1.5	A
Total Power Dissipation	P _D @T _A =25°C	0.8	W
Thermal Resistance Junction-ambient ³ Max.	R _{thj-a}	150	°C/W
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 ~ +150	°C

Device Marking

WTL2622=2622

Electrical Characteristics (T_j = 25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV _{DSS}	50	-	-	V	V _{GS} =0, I _D =250uA
Breakdown Voltage Temperature Coefficient	ΔBV _{DSS} / ΔT _j	-	0.06	-	V/°C	Reference to 25°C, I _D =1mA
Gate Threshold Voltage	V _{GS(th)}	1.0	-	3.0	V	V _{DS} =V _{GS} , I _D =250uA
Forward Transconductance	g _{fs}	-	600	-	mS	V _{DS} =10V, I _D =500mA
Gate-Source Leakage Current	I _{GSS}	-	-	±30	uA	V _{GS} = ±20V
Drain-Source Leakage Current(T _j =25°C)	I _{DSS}	-	-	10	uA	V _{DS} =50V, V _{GS} =0
Drain-Source Leakage Current(T _j =70°C)		-	-	100	uA	V _{DS} =40V, V _{GS} =0
Static Drain-Source On-Resistance	R _{DS(ON)}	-	-	1.8	fl	V _{GS} =10V, I _D =500mA
		-	-	3.2		V _{GS} =4.5V, I _D =200mA
Total Gate Charge ²	Q _g	-	1	1.6	nC	I _D =500mA V _{DS} =40V V _{GS} =4.5V
Gate-Source Charge	Q _{gs}	-	0.5	-		
Gate-Drain ("Miller") Charge	Q _{gd}	-	0.5	-		
Turn-on Delay Time ²	T _{d(on)}	-	12	-	ns	V _{DS} =25V I _D =500mA V _{GS} =10V R _G =3.3fl R _D =50fl
Rise Time	T _r	-	10	-		
Turn-off Delay Time	T _{d(off)}	-	56	-		
Fall Time	T _f	-	29	-		
Input Capacitance	C _{iss}	-	32	50	pF	V _{GS} =0V V _{DS} =25V f=1.0MHz
Output Capacitance	C _{oss}	-	8	-		
Reverse Transfer Capacitance	C _{rss}	-	6	-		

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V _{SD}	-	-	1.3	V	I _S =600mA, V _{GS} =0V

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width ≤ 300us, duty cycle ≤ 2%.

3. Surface mounted on 1 in² copper pad of FR4 board, t ≤ 5sec; 250°C/W when mounted on Min. copper pad.

Characteristics Curve

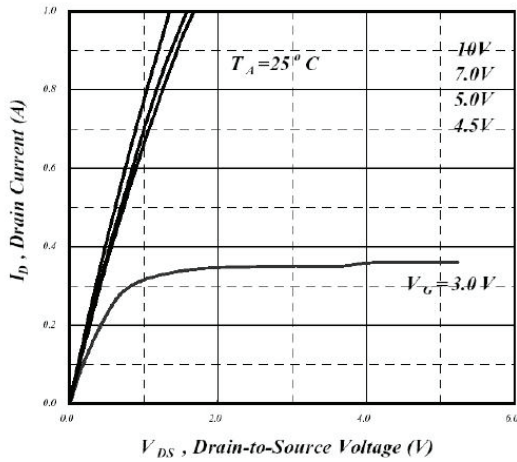


Fig 1. Typical Output Characteristics

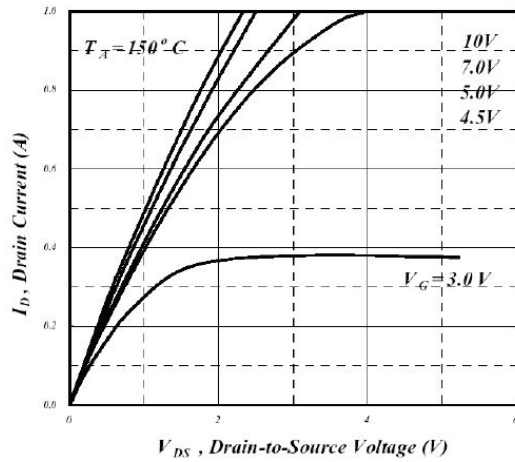


Fig 2. Typical Output Characteristics

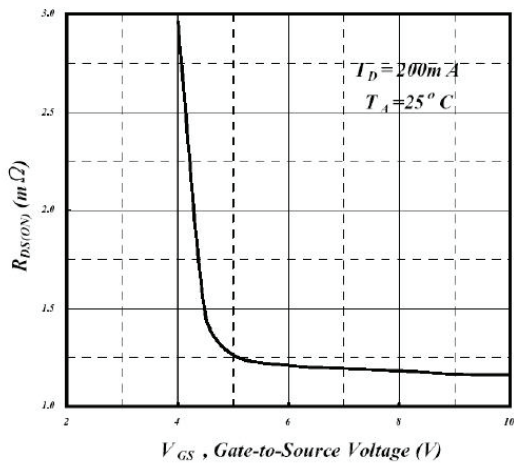


Fig 3. On-Resistance v.s. Gate Voltage

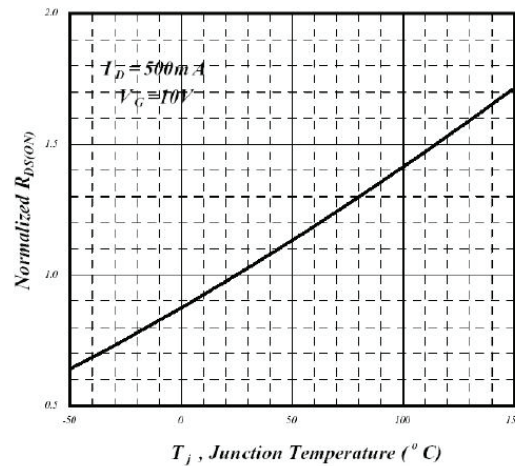


Fig 4. Normalized On-Resistance v.s. Junction Temperature

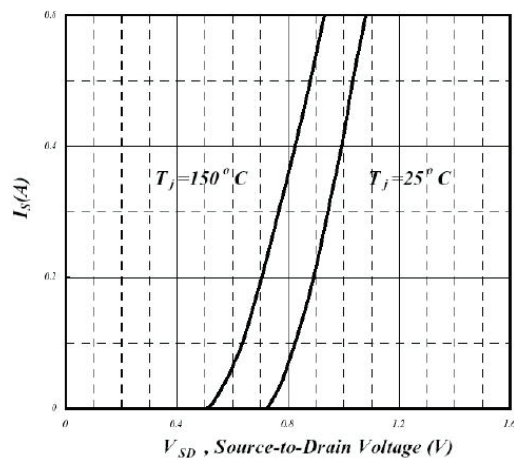


Fig 5. Forward Characteristics of Reverse Diode

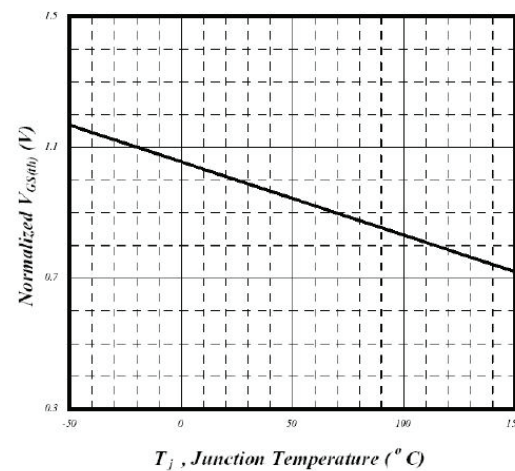


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

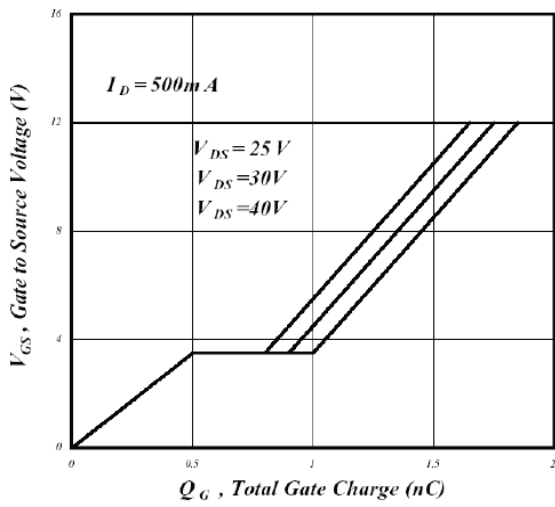


Fig 7. Gate Charge Characteristics

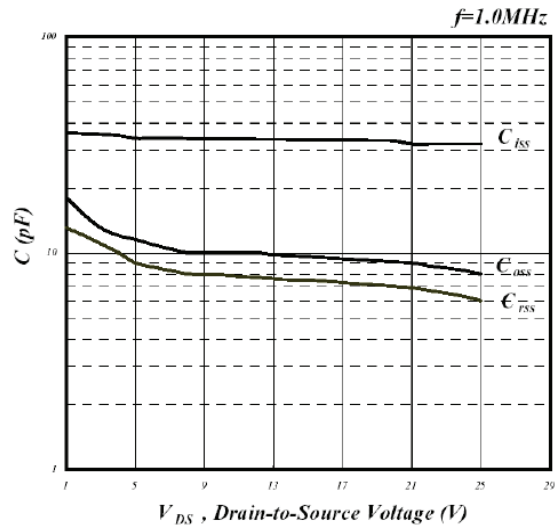


Fig 8. Typical Capacitance Characteristics

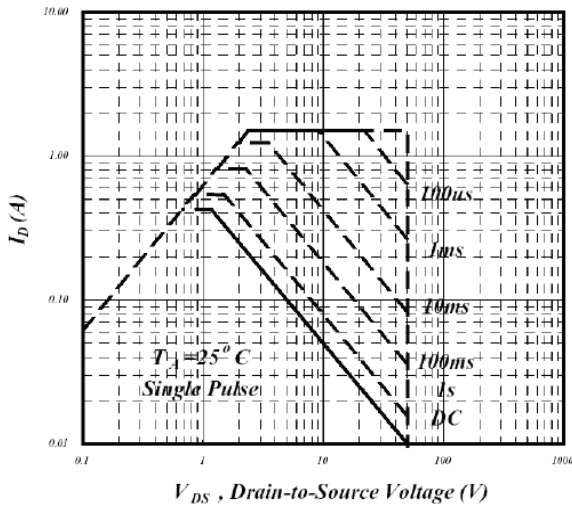


Fig 9. Maximum Safe Operating Area

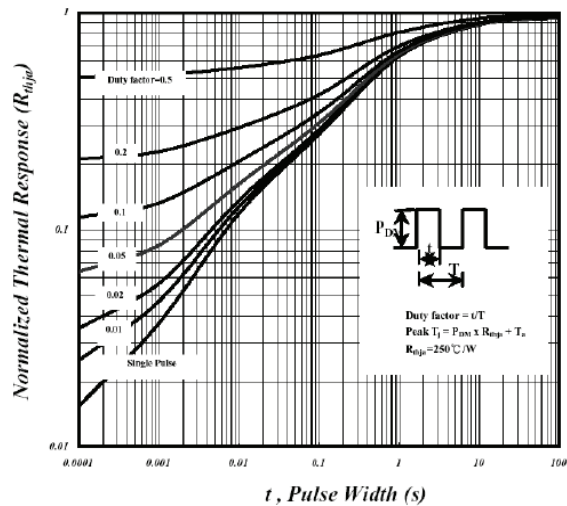


Fig 10. Effective Transient Thermal Impedance

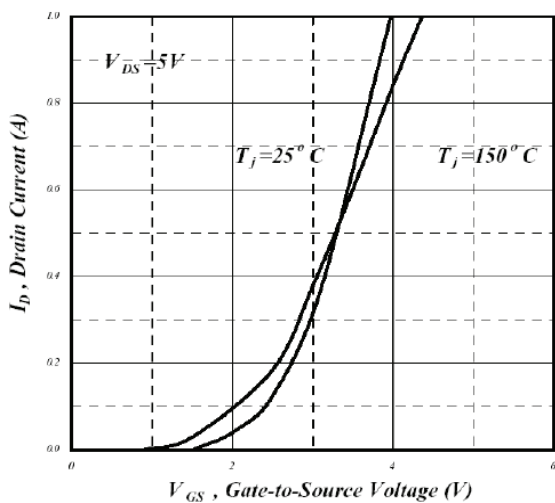


Fig 11. Transfer Characteristics

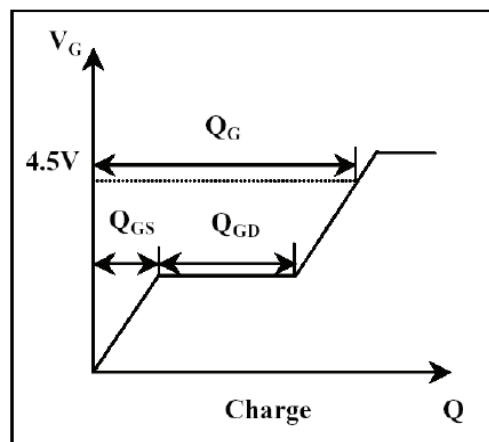
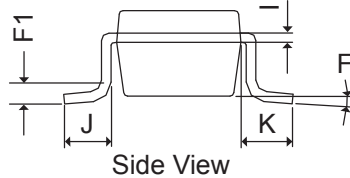
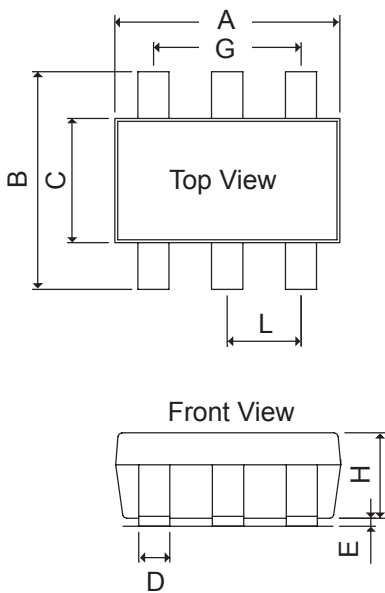


Fig 12. Gate Charge Waveform

SOT-26 Outline Dimension

Unit:mm



SOT-26		
Dim	Min	Max
A	2.70	3.10
B	2.60	3.00
C	1.40	1.80
D	0.30	0.55
E	0.00	0.10
F	0°	10°
F1	0.08	0.25
G	1.90 REF	
H	1.20 REF	
I	0.12 REF	
J	0.37 REF	
K	0.60 REF	
L	0.95 REF	